

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/687,172	LIN ET AL.
Examiner	Art Unit	
Sam K. Ahn	2611	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
all classes	all subclasses	8/21 -	CR
above	above	8/27	CR